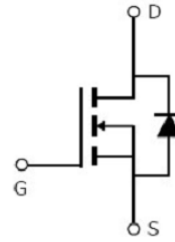
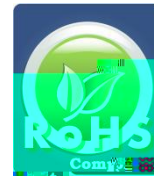




V_{DSS}	100V
$R_{DS(on)}$	4.2m (typ.)
I_D	140A



- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150 operating temperature



It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	140	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	85	
I_{DM}	Pulsed Drain Current	417	
$P_D @ T_C = 25^\circ C$	Power Dissipation	266	W
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy @ $L=0.5mH$	473	mJ
I_{AS}	Avalanche Current	52	A
$T_J T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$



Symbol	Characterizes	Typ.	Max.	Units
R _{JC}	Junction-to-case	—	0.47	/W
R _{JA}	Thermal Resistance, Junction-to-Ambient	—	62	/W

@T_A=25 unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	100	—	—	V	V _{GS} = 0V, I _D = 250μA
R _{DS(on)}	Static Drain-to-Source on-resistance	—	4.2	6	m	V _{GS} =10V, I _D =20A
V _{GS(th)}	Gate threshold voltage	2	—	4	V	V _{DS} = V _{GS} , I _D =250μA
I _{DSS}	Drain-to-Source leakage current	—	—	1	μA	V _{DS} =100V, V _{GS} = 0V
I _{GSS}	Gate-to-Source forward leakage	—	—	100	nA	V _{GS} =20V
		—	—	-100		V _{GS} = -20V
Q _g	Total gate charge	—	43	—	nC	I _D = 20A,
Q _{gs}	Gate-to-Source charge	—	9.5	—		V _{DS} =50V,
Q _{gd}	Gate-to-Drain("Miller") charge	—	11	—		V _{GS} = 10V



Typical Electrical and Thermal Characteristics

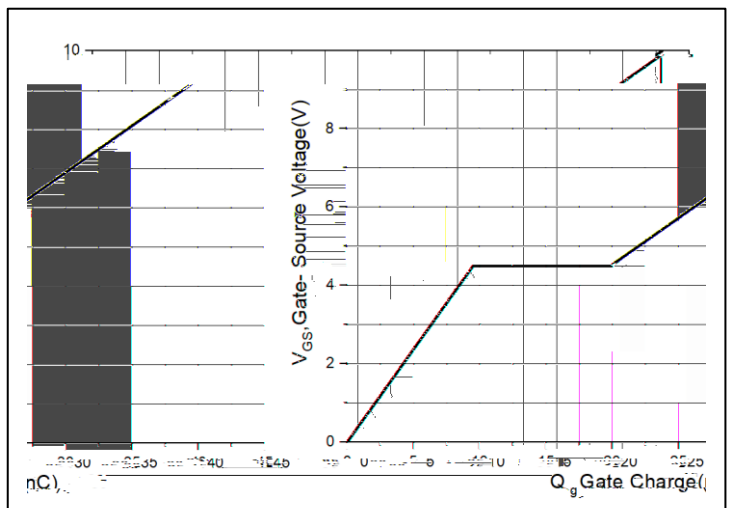
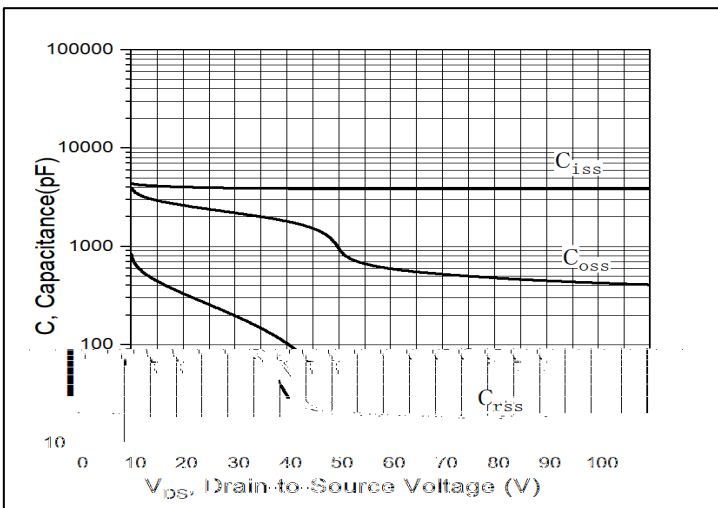
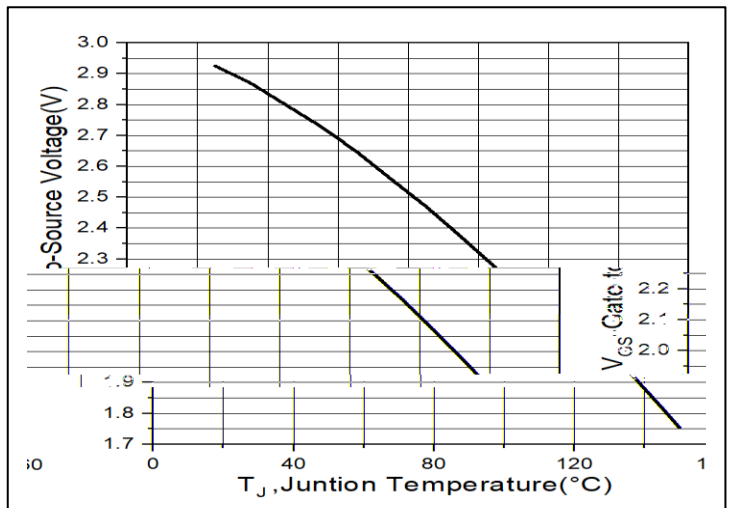
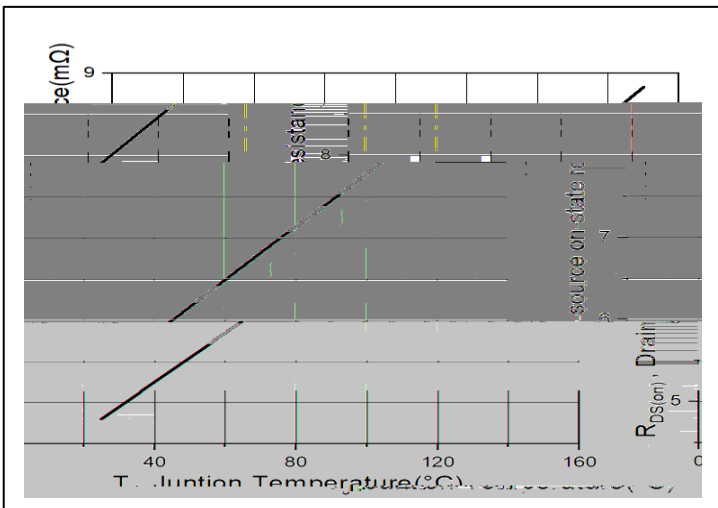
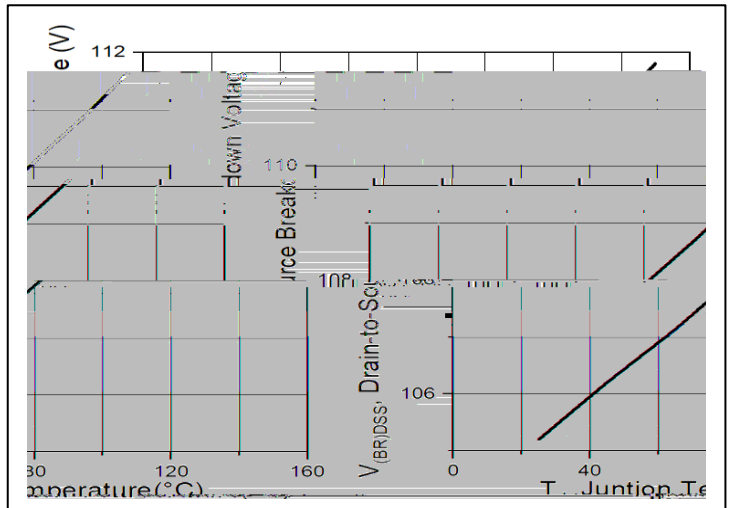
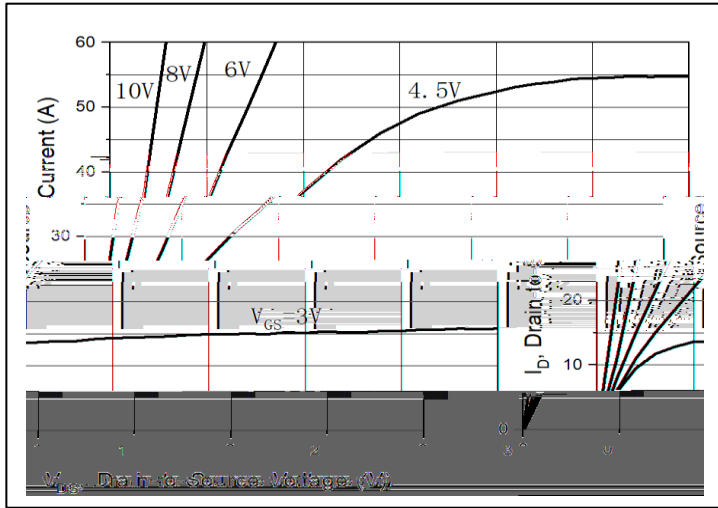


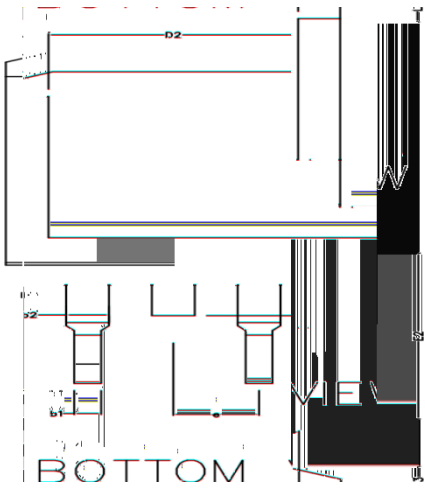
Figure 5. Capacitance

Figure 6. Gate Charge

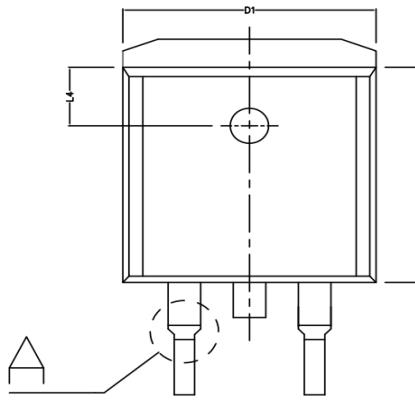




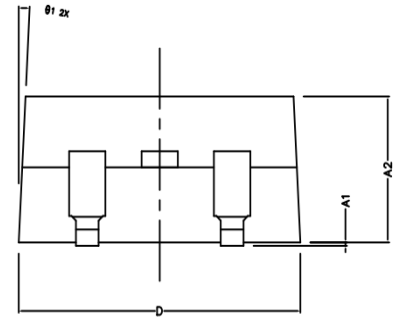
Option 2



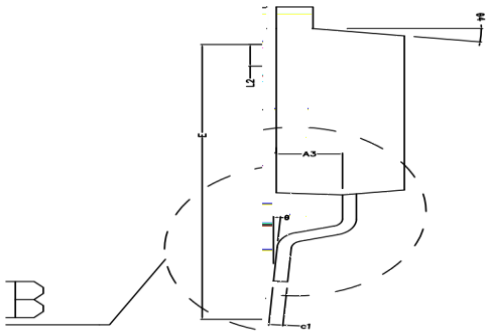
BOTTOM



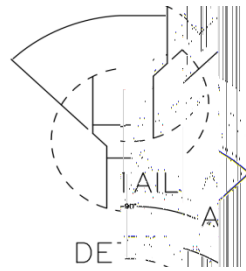
TOP VIEW



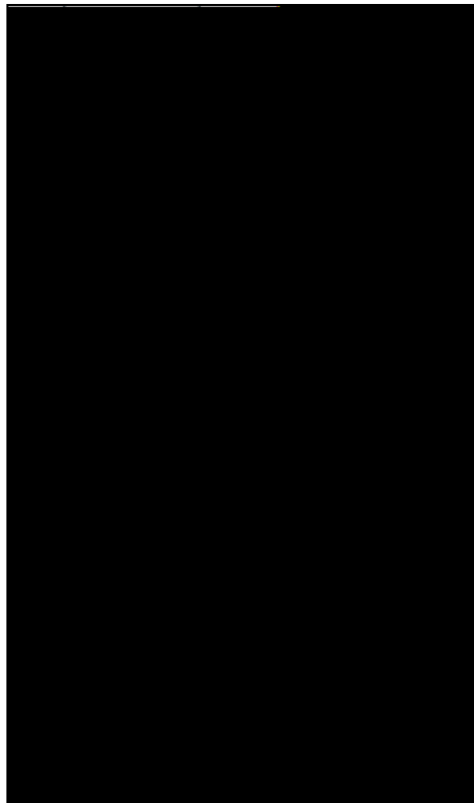
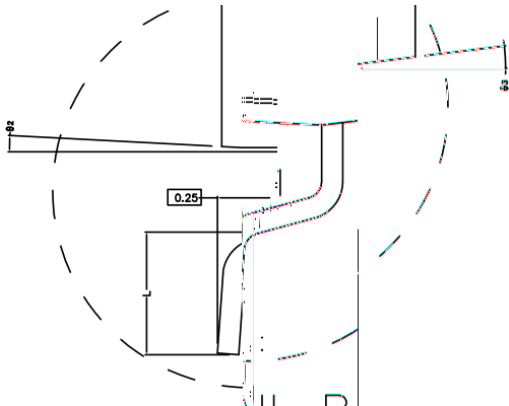
SIDE VIEW



PARTIAL VIEW
SECTION



DETAIL





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